

Notice of References Cited	Application/Control No. 10/585,408		Applicant(s)/Patent Under Reexamination NOZAWA ET AL.	
	Examiner Keath T. Chen		Art Unit 1792	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,316,579	05-1994	McMillan et al.	118/50
*	B	US-2003/0161946	08-2003	Moore et al.	427/236
*	C	US-2003/0034056	02-2003	Amai et al.	134/93
	D	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	English translation of JP 2001-156047, Hiroyuki et al., 08-2001 (applicant's IDS)			
	V	English translation of JP 2003-174016, Seikyu et al., 06-2003 (applicant's IDS)			
	W				
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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